

Search Notes

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Examiner

Steven J. Fulk

Applicant(s)/Patent under
Reexamination

TASI ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
438	38	8/9/2005	SJF

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
438/22-47; 257/79-103,778,780,787-795,617-626 (text search only - see search history printout)	8/10/2005	SJF
IEEE Xplore, Science Direct (see search history printout)	8/10/2005	SJF
"III-Nitride S/C: Electrical, Structural, and Defects Properties," O. Manasreh, 2000.	8/10/2005	SJF
"Gallium Nitride and Related Materials," F.A. Ponce, MRS Symposium Proceedings, Volume 395, 1996.	8/8/2005	SJF
"Gallium Nitride I," J. Pankove, Volume 50, 1998. "Gallium Nitride II," J. Pankove, Volume 57, 1999.	8/9/2005	SJF
"Optoelectronic Properties of Semiconductors and Superlattices," M.O. Manasreh, Volume 16, 2003.	8/9/2005	SJF
"Introduction to Nitride Semiconductor Blue Lasers and LEDs," S. Nakamura, 2000.	8/9/2005	SJF
"The Blue Laser Diode," S. Nakamura, 2000.	8/9/2005	SJF